## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | BACKES ET AL. | Examiner | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0232200	10-2005	Jeong et al.	370/331
*	В	US-2005/0117524	06-2005	Lee et al.	370/254
*	С	US-2004/0146021	07-2004	Fors et al.	370/331
*	D	US-7,173,918	02-2007	Awater et al.	370/332
*	Е	US-6,657,981	12-2003	Lee et al.	370/331
*	F	US-2004/0203783	10-2004	Wu et al.	455/436
*	G	US-2003/0087646	05-2003	Funato et al.	455/456
*	Η	US-2002/0142771	10-2002	Saifullah et al.	455/436
*	-	US-7,133,386	11-2006	Holur et al.	370/331
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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